



Callaghan Innovation

Measurement Standards Laboratory of New Zealand

Client Number 8

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Authorised Representative

Dr Blair Hall
Principal Research Scientist and Quality Manager

Programme

Metrology & Calibration Laboratory

Accreditation Number 1

Initial Accreditation Date 30 July 2004


Conformance Standard

ISO/IEC 17025:2017

General requirements for the competence of testing and calibration laboratories

Laboratory Services Summary

- 5.01 Engineers' Limit Gauges
- 5.02 Jigs, Fixtures, Cutting Tools and Components
- 5.05 Geometric Form
- 5.11 Working Standards of Length and Angle
- 5.12 Precision Measuring Instruments
- 5.14 Laser Frequency
- 5.21 Masses
- 5.31 Volumetric Equipment
- 5.32 Density
- 5.33 Hydrometers
- 5.35 Hygrometry
- 5.41 Barometers
- 5.42 Differential Pressure Measuring Devices (including Manometers)
- 5.43 Pressure Gauge Testers and Pressure Balances
- 5.44 Pressure and Vacuum
- 5.61 Temperature Measuring Equipment
- 5.65 Photometers and Radiometers
- 5.66 Lamps, LEDs, Lasers and Other Light Sources
- 5.67 Colour of Light Sources and Colorimeters
- 5.68 Optical Properties of Materials: Spectral
- 5.69 Optical Properties of Materials: Spectrally integrated
- 5.82 Resistors, Resistance Boxes and Potential Dividers
- 5.84 Capacitors

| | | | | |
|--------------------------------------|---|----------|---------------|--------------|
| Operations Manager Authorisation: |  | Issue 58 | Date:02/11/20 | Page 1 of 23 |
|--------------------------------------|---|----------|---------------|--------------|

CERTIFICATE OF ACCREDITATION



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|------|--|
| 5.85 | Inductors and Transformers |
| 5.86 | Voltage Standards and Current Standards |
| 5.87 | Transfer Instruments (AC/DC) |
| 5.88 | Calibrators for Instrumentation |
| 5.89 | Indicating Instruments and Recording Instruments |
| 5.90 | Bridges, Potentiometers and Test Sets |
| 5.91 | Frequency Measurement and Time Measurement |
| 5.92 | Waveform Measurement |
| 5.93 | Signal Sources |
| 5.97 | High Voltage Testing |

Key Technical Personnel

| | |
|------------------------|--|
| Dr Laurie Christian | 5.82, 5.85(d), 5.86, 5.87, 5.88, 5.89, 5.90, 5.92(b), 5.93(b), 5.97 |
| Dr Mark Clarkson | 5.41, 5.42, 5.43, 5.44 |
| Mr David Cochrane | 5.05(d)(ii) |
| Dr Adam Dunford | 5.91(a)(c)(d)(g), 5.92(a)(c), 5.93(a) |
| Dr Murray Early | 5.82, 5.86, 5.87, 5.88, 5.89(a-d,i), 5.90(a,f,g), 5.92(b), 5.93(b), 5.97 |
| Dr Lucy Forde | 5.05(d)(ii)(h), 5.11(f)(i)(n), 5.12, 5.14 |
| Ms Eleanor Howick | 5.01, 5.02, 5.05, 5.11, 5.12, 5.14 |
| Mr Keith Jones | 5.82, 5.84, 5.85, 5.86, 5.87, 5.88(a,c,e), 5.89(a,c,e,f,g,h,i,l), 5.90, 5.92(b), 5.93(b), 5.97 |
| Dr Annette Koo | 5.68, 5.69 |
| Dr Tim Lawson | 5.82(a), 5.86(b), 5.88(c), 5.89(c) |
| Dr Jeremy Lovell-Smith | 5.35 |
| Dr Peter Mcdowall | 5.41, 5.44 |
| Mr Greg Reid | 5.21, 5.31, 5.32, 5.33 |
| Dr Peter Saunders | 5.61, 5.82(a), 5.90(a)(c) |
| Dr Francois Shindo | 5.65, 5.66, 5.67 |
| Mr Tom Stewart | 5.82(a), 5.84, 5.85(a,d), 5.88(b,d,e,f), 5.89(a,b,c,d-h,l), 5.90(c,f,g) |
| Mr Neil Swift | 5.05(d)(ii), 5.65, 5.66, 5.67, 5.68, 5.69 |
| Mr Yang Yenn Tan | 5.65 |
| Dr Emile Webster | 5.61(a)(b)(c)(p) |
| Dr David Rodney White | 5.35, 5.61, 5.82(a), 5.90(a)(c) |
| Mr Chris Young | 5.01, 5.02, 5.05, 5.11, 5.12, 5.14 |

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|--------------------------------------|--|----------|---------------|--------------|
| Operations Manager Authorisation: | | Issue 58 | Date:02/11/20 | Page 2 of 23 |
|--------------------------------------|--|----------|---------------|--------------|



Callaghan Innovation
 Metrology & Calibration Laboratory
SCOPE OF ACCREDITATION

Accreditation Number 1

The uncertainty of a Calibration and Measurement Capability (CMC) is expressed as an expanded uncertainty with a level of confidence of approximately 95% ^{Note1}.

Measurement results are traceable to the International System of Units (SI)

Calibrations are generally performed at the premises of the accredited laboratory, although some may be carried out in the field and some at customer premises.

| | | |
|-----------|------------|-----------------|
| Measurand | Conditions | CMC Uncertainty |
|-----------|------------|-----------------|

5.01 Engineers' Limit Gauges

(a) Plain plug, ring and gap gauges. Taper plug and ring gauges.

Setting plug gauges by comparison with gauge blocks

| | | |
|---------------|-----------------|--------------------------|
| Mean diameter | 0.5 mm to 25 mm | Q(130, 1.4L) nm, L in mm |
| Mean diameter | 25 mm to 300 mm | Q(95, 1.8L) nm, L in mm |

Setting ring gauges by comparison with gauge blocks

| | | |
|---------------|----------------|-------------------------|
| Mean diameter | 1 mm to 300 mm | Q(95, 1.8L) nm, L in mm |
|---------------|----------------|-------------------------|

Where $Q(a,b) = \sqrt{a^2 + b^2}$

(e) Position and receiver gauges involving both linear and angular measurements.

| | | |
|---------------------|----------------|---------|
| Lobster tail gauges | 54 mm to 60 mm | 0.01 mm |
|---------------------|----------------|---------|

(g) Other gauges involving measurements similar to those under (a) and including depth gauges, height gauges and gauges involving plane coordinated position of holes and spigots.

Step gauge face spacing by comparison with end standards on CMM

| | | |
|-----------------|--|--|
| 90 mm to 700 mm | | Q(0.7, 1.2 x 10 ⁻³ L) µm, L in mm |
|-----------------|--|--|

2D CMM artefacts (ball plate centre coordinates) by comparison with end standards on CMM

| | | |
|---------------------------------------|--|--|
| Side length between 100 mm and 600 mm | | Q(0.9, 1.3 x 10 ⁻³ L) µm, L in mm |
|---------------------------------------|--|--|

5.02 Jigs, Fixtures, Cutting Tools and Components

Measurement of components/objects on CMM

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|-----------------------------------|--|----------|---------------|--------------|
| Operations Manager Authorisation: | | Issue 58 | Date:02/11/20 | Page 3 of 23 |
|-----------------------------------|--|----------|---------------|--------------|



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Metrology & Calibration Laboratory
SCOPE OF ACCREDITATION

Accreditation Number 1

Error of indicated size 1 mm to 800 mm (1.6 + 3.5L) µm, L in m

Measurement of components/objects on Profile Projector

Error of indicated size up to 200 mm x 200 mm Q(0.76, 12.6L) µm, L in m

5.05 Geometric Form

(b) Roundness

Variability in roundness Range of diameters

0 µm to 400 µm 1 mm to 300 mm Q(0.025, 0.018R) µm, R in µm

(d) Flatness of Optical Flat, Parallelism, Wedge Angle of Optical Wedge or Flat

i) Length section

Parallelism Range of diameters
0 µm to 10 µm 10 mm to 35 mm 0.08 µm

Flatness Range of diameters
0 µm to 2.5 µm 10 mm to 35 mm 0.06 µm

ii) Photometry section

Flatness of optical flats, one-axis or whole surface

Up to 150 mm diameter 22 nm
Up to 250 mm diameter 33 nm

(h) Levelness

Levelling of dynamic weigh station sites by measurement of deviation from a horizontal plane (calibration carried out on site)

Deviation in height Horizontal range
1.8 m to 60 m Q(41, 7.1L) µm, L in m is the horizontal distance to staff

5.11 Working Standards of Length and Angle

(a) Gauge blocks and accessories

Measurement of central length

By interferometry 0.5 mm to 103 mm Q(17, 0.15L) nm, L in mm

Operations Manager
Authorisation:

Issue 58

Date:02/11/20

Page 4 of 23



Callaghan Innovation
Metrology & Calibration Laboratory
SCOPE OF ACCREDITATION

Accreditation Number 1

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| By comparison | 0.1 mm to 103 mm | Q(36, 1.4L) nm, L in mm |
| Measurement of variation in length | | Q(30, 0.35L) nm, L in mm |
| (b) Length bars and accessories | | |
| Measurement of central length and variation in length | | |
| Long gauge blocks by comparison with gauge blocks using the Horizontal Federal | | |
| 100 mm to 300 mm | | Q(91, 1.3L) nm, L in mm |
| Measurement of variation in length | | Q(34, 0.35L) nm, L in mm |
| Long gauge blocks by comparison with gauge blocks using the LBC | | |
| 100 mm to 1500 mm | | Q(370, 0.48L) nm, L in mm |
| Measurement of variation in length | | 100 nm |
| (f) Precision linear scales | | |
| Engineer or machinist scale-line spacing | | |
| 0.1 m to 4 m | | Q(10, 8.2L) µm, L in m |
| (h) Precision graticules including stage micrometers and haemocytometer counting chambers | | |
| 1 µm to 10 mm | | 0.5 µm |
| (i) Surveying tapes and petroleum dip tapes | | |
| 4 m to 50 m | | Q(10, 10.5L) µm, L in m |
| Surveyor levelling rods | | |
| 0.5 m to 3 m | | Q(10, 10L) µm, L in m |
| (n) Geodetic Baselines (calibrations carried out on site) | | |
| Interval distances | 2 m to 1500 m | Q(0.3, 0.6 x 10 ⁻³ L) mm, L in m |
| 5.12 Precision Measuring Instruments | | |
| (a) Length measuring machines | | |

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|--------------------------------------|--|----------|---------------|--------------|
| Operations Manager Authorisation: | | Issue 58 | Date:02/11/20 | Page 5 of 23 |
|--------------------------------------|--|----------|---------------|--------------|



Callaghan Innovation
Metrology & Calibration Laboratory
SCOPE OF ACCREDITATION

Accreditation Number 1

Electronic distance measuring machines (EDMs)

Error of indicated displacement 1 m to 206 m $Q(0.13, 7 \times 10^{-4}L)$ mm, L in m

Error of indicated frequency 5 MHz to 100 MHz $0.16 \times 10^{-6}L \times \text{frequency}$

Error of prism constant 0.26 mm

5.14 Laser Frequency

(a) Stabilised lasers of the mise en pratique

Absolute frequency 473 612 GHz 25 kHz

(b) Other stabilised lasers

Absolute frequency 473 612 GHz 0.2 MHz

5.21 Masses

- (a) Examination of laboratory standards of mass
- (b) Examination of industrial standards of mass
- (c) Determination of the mass of solid objects

| | |
|-------------------|----------------------|
| 1 mg to 100 mg | 0.4 µg to 0.7 µg |
| 0.1 g to 1 g | 0.7 µg to 1.6 µg |
| 1 g to 10 g | 1.6 µg to 4 µg |
| 10 g to 100 g | 4 µg to 8 µg |
| 0.1 kg to 1 kg | 8 µg to 40 µg |
| 1 kg to 10 kg | 1.1×10^{-7} |
| 10 kg to 20 kg | 1.6×10^{-7} |
| 20 kg to 300 kg | 1.5×10^{-6} |
| 300 kg to 1000 kg | 10 g to 16 g |

5.31 Volumetric Equipment

(a) Examination of laboratory volumetric glassware including examination for compliance with the Class A or Class B requirements of the relevant national or international standards

0.02 mL to 2 mL 0.0002 mL

(b) Examination of other types of volumetric apparatus

0.002 L to 50 L 0.01 %

Operations Manager
Authorisation:

Issue 58

Date:02/11/20

Page 6 of 23



Callaghan Innovation
 Metrology & Calibration Laboratory
SCOPE OF ACCREDITATION

Accreditation Number 1

5.32 Density

(a) Density of solids

1400 kg/m³ to 3000 kg/m³
 7800 kg/m³ to 8200 kg/m³

1.0 x 10⁻⁵
 1.5 x 10⁻⁵

(b) Density of liquids

600 kg/m³ to 2000 kg/m³

2.0 x 10⁻⁵

5.33 Hydrometers

- (a) Density hydrometers
- (b) Specific gravity hydrometers
- (c) Brix hydrometers
- (d) Proof spirit hydrometers

600 kg/m³ to 2000 kg/m³

2.0 x 10⁻⁵

5.35 Hygrometry

(a) Humidity measuring devices

i) Dew point hygrometers

-70 °C to 0 °C
 0 °C to 40 °C
 40 °C to 70 °C

0.2 °C to 0.06 °C
 0.06 °C
 0.06 °C to 0.12 °C

ii) Relative humidity hygrometers

10 % to 95 %
 (Temperature between 0 °C and 70 °C)

0.006 x *h* %
h is relative humidity expressed
 as a percentage, that is % rh

iii) Air temperature

0 °C to 70 °C

0.1 °C

5.41 Barometric indicators or transducers

Aneroid barometers (including digital barometers)

50 kPa to 90 kPa
 90 kPa to 110 kPa
 110 kPa to 130 kPa

2.0 x 10⁻⁵
 1.0 x 10⁻⁵
 2.0 x 10⁻⁵

Operations Manager
 Authorisation:

Issue 58

Date:02/11/20

Page 7 of 23



Callaghan Innovation
 Metrology & Calibration Laboratory
SCOPE OF ACCREDITATION

Accreditation Number 1

5.42 Differential Pressure Measuring Devices (including Manometers)

- (a) Diaphragm types
- (b) Liquid column types, inclined and vertical
- (c) Transducers and transmitters
- (d) Other types

1 Pa to 10000 Pa $(6 \times 10^{-3} + 4.5 \times 10^{-5} p)$
Pa, p in Pa

5.43 Pressure Gauge Calibrators and Pressure Balances

- i) Absolute pressure – gas medium

8 kPa to 550 kPa 2×10^{-5}
 550 kPa to 7000 kPa 6×10^{-5}

- ii) Gauge pressure – gas medium

-100 kPa to -10 kPa 7×10^{-5}
 -10 kPa to -1 kPa 200 mPa to 100 mPa,
decreasing linearly
 1 kPa to 8 kPa 100 mPa to 160 mPa,
increasing linearly
 8 kPa to 550 kPa 2×10^{-5}
 550 to 11000 kPa 6×10^{-5}

- iii) Gauge pressure – liquid medium

0.1 MPa to 17 MPa $(1 \times 10^{-4} + 6.6 \times 10^{-5} p)$
MPa (p in MPa)
 17 MPa to 280 MPa $(6.6 \times 10^{-5} p + 7 \times 10^{-7} p^2)$
MPa (p in MPa)

5.44 Pressure and Vacuum

- (a) Pressure gauges
- (b) Vacuum gauges
- (c) Pressure transducers
- (d) Pressure recorders

- i) Absolute pressure – gas medium

8 kPa to 90 kPa 2×10^{-5}
 90 kPa to 110 kPa 1×10^{-5}
 110 kPa to 550 kPa 2×10^{-5}

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|--------------------------------------|--|----------|---------------|--------------|
| Operations Manager Authorisation: | | Issue 58 | Date:02/11/20 | Page 8 of 23 |
|--------------------------------------|--|----------|---------------|--------------|



Callaghan Innovation
Metrology & Calibration Laboratory
SCOPE OF ACCREDITATION

Accreditation Number 1

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| 550 kPa to 7000 kPa | 6×10^{-5} |
| ii) Gauge pressure – gas medium | |
| -96 kPa to 8 kPa | 0.0031 kPa |
| 8 kPa to 90 kPa | 2×10^{-5} |
| 90 kPa to 110 kPa | 1×10^{-5} |
| 110 kPa to 550 kPa | 2×10^{-5} |
| 550 to 11000 kPa | 6×10^{-5} |
| iii) Absolute pressure – liquid medium | |
| 0.3 MPa to 17 MPa | $(1 \times 10^{-4} + 6.6 \times 10^{-5}p)$ MPa (p in MPa) |
| 17 MPa to 280 MPa | $(6.6 \times 10^{-5}p + 7 \times 10^{-7}p^2)$ MPa (p in MPa) |
| iv) Gauge pressure – liquid medium | |
| 0.2 MPa to 17 MPa | $(1 \times 10^{-4} + 6.6 \times 10^{-5}p)$ MPa (p in MPa) |
| 17 MPa to 280 MPa | $(6.6 \times 10^{-5}p + 7 \times 10^{-7}p^2)$ MPa (p in MPa) |

5.61 Temperature Measuring Equipment

| | |
|---|----------|
| (a) Noble-metal thermocouples | |
| 0 °C to 962 °C | 0.026 °C |
| 962 °C to 1100 °C | 0.22 °C |
| (b) Base-metal thermocouples | |
| 0 °C to 1100 °C | 1.6 °C |
| (c) Platinum (and other metallic) resistance thermometers | |
| Contact thermometers, including Standard PRTs at the following fixed points | |
| Argon triple point (-189.3442 °C) | 1 mK |
| Mercury triple point (-38.8344 °C) | 0.4 mK |
| Water triple point (0.01 °C) | 0.1 mK |
| Gallium melting point (29.7646 °C) | 0.19 mK |
| Indium freezing point (156.5985 °C) | 0.56 mK |
| Tin freezing point (231.928 °C) | 0.85 mK |
| Zinc freezing point 419.527 °C) | 1.9 mK |

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|--------------------------------------|--|----------|---------------|--------------|
| Operations Manager Authorisation: | | Issue 58 | Date:02/11/20 | Page 9 of 23 |
|--------------------------------------|--|----------|---------------|--------------|



Callaghan Innovation
 Metrology & Calibration Laboratory
SCOPE OF ACCREDITATION

Accreditation Number 1

Aluminium freezing point (660.323 °C) 10 mK
 Silver freezing point (961.78 °C) 20 mK

(j) Radiation thermometers

Direct reading, single spot radiation thermometers and thermal imagers

-25 °C to 1100 °C 0.6 °C

(p) Other direct reading temperature measuring systems, including Industrial PRTs

-190 °C to 0 °C (2.4 - 0.005 x t) mK, t in °C
 0 °C to 200 °C (2.4 + 0.008 x t) mK, t in °C
 200 °C to 550 °C (4.0 + 0.03 x (t - 200)) mK, t in °C

5.65 Photometers and Radiometers

(a) Photometers

10 lux to 3000 lux 0.8 %

(b) Illuminance meters

0.005 lux to 10 lux 3 %
 10 lux to 3000 lux 0.8 %
 3000 lux to 30000 lux 3 %

(c) Luminance meters

0.5 cd/m² to 800 cd/m² 1.6 %
 800 cd/m² to 27000 cd/m² 7 %
 27000 cd/m² to 33000 cd/m² 11 %

(d) UV meters

For Irradiance levels of 1 µW.cm⁻² to 5000 µW.cm⁻²

240 nm to 270 nm 5 %
 270 nm to 310 nm 2.3 %
 310 nm to 380 nm 2.5 %

For radiant exposure levels greater than 1.3 µJ.cm⁻²

240 nm to 270 nm 20 % to 5 %, decreases with exposure time

Operations Manager
 Authorisation:

Issue 58

Date:02/11/20

Page 10 of 23



Callaghan Innovation
Metrology & Calibration Laboratory
SCOPE OF ACCREDITATION

Accreditation Number 1

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| 270 nm to 310 nm | 19 % to 2.3 %, decreases with exposure time |
| 310 nm to 380 nm | 19 % to 2.5 %, decreases with exposure time |
| (g) Laser power meters | |
| Laser lines from 450 nm to 500 nm | 0.45 % to 0.23 %, decreases linearly with wavelength |
| Laser lines from 500 nm to 550 nm | 0.23 % to 0.15 %, decreases linearly with wavelength |
| Laser lines from 550 nm to <650 nm | 0.15 % |
| Laser lines from 650 nm to 750 nm | 0.17 % |
| Laser lines from 750 nm to 800 nm | 0.19 % |
| (h) Detector spectral responsivity measurement | |
| Discrete wavelengths | |
| Laser lines from 450 nm to 500 nm | 0.45 % to 0.23 %, decreases linearly with wavelength |
| Laser lines from 500 nm to 550 nm | 0.23 % to 0.15 %, decreases linearly with wavelength |
| Laser lines from 550 nm to <650 nm | 0.15 % |
| Laser lines from 650 nm to 750 nm | 0.17 % |
| Laser lines from 750 nm to 800 nm | 0.19 % |
| The below CMCs are for spectral power levels of 0.1 $\mu\text{W}\cdot\text{nm}^{-1}$ to 10 $\mu\text{W}\cdot\text{nm}^{-1}$ and corresponding irradiance levels using appropriate apertures. For spectral power levels below 0.1 $\mu\text{W}\cdot\text{nm}^{-1}$ uncertainties will increase. | |
| 240 nm to <300 nm | 1.4 % |
| 300 nm to <340 nm | 0.98 % |
| 340 nm to 360 nm | 1.02 % to 0.98 %, decreases linearly with wavelength |
| 360 nm to 380 nm | 0.98 % |
| 380 nm to 450 nm | 0.98% to 0.45%, decreases linearly with wavelength |
| 450 nm to 800 nm | Same as for discrete wavelengths – see (g) above |
| 800 nm to 950 nm | 0.19% to 0.33%, increases linearly with wavelength |

5.66 Lamps, LEDs, Lasers and Other Light Sources

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|-----------------------------------|--|----------|---------------|---------------|
| Operations Manager Authorisation: | | Issue 58 | Date:02/11/20 | Page 11 of 23 |
|-----------------------------------|--|----------|---------------|---------------|



Callaghan Innovation
 Metrology & Calibration Laboratory
SCOPE OF ACCREDITATION

Accreditation Number 1

Calibrations within 5.66 may be offered in the field as well as in the laboratory. An increase in uncertainty due to environmental conditions and other influence variables present in the field may need to be applied.

- (a) Lamps: luminous intensity
 - 10 cd to 5000 cd 0.8 %
- (e) Illuminance
 - 0.005 lux to 30000 lux 3 %
- (f) General sources: spectral irradiance
 - 250 nm to 350 nm 0.0001 W/(m².nm) to 0.5 W/(m².nm) 2.6 % to 1.6 %
 - 350 nm to 850 nm 0.001 W/(m².nm) to 0.5 W/(m².nm) 1.6 % to 1.4 %
- (h) Photoluminescent materials
 - from 0.5 mcd/m² 0.5 mcd/m² or 15 %, whichever is greater

5.67 Colour of Light Sources and Colorimeters

Calibrations within 5.67 may be offered in the field as well as in the laboratory. An increase in uncertainty due to environmental conditions and other influence variables present in the field may need to be applied.

- (a) General sources:
 - Colour emitted in CIE x, y colour space 0.0005 to 0.005 in x and y, varies with measurand
 - Colour emitted in CIE u, v colour space 0.0007 in u and v
- (d) Lamps:
 - Correlated colour temperature 2700 K to 3000 K 20 K

5.68 Optical Properties of Materials: Spectral

- (a) Regular transmittance (T) and optical density or absorbance (OD)
 - Bandwidth 1 nm to 3 nm

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|--------------------------------------|--|----------|---------------|---------------|
| Operations Manager Authorisation: | | Issue 58 | Date:02/11/20 | Page 12 of 23 |
|--------------------------------------|--|----------|---------------|---------------|



Callaghan Innovation
Metrology & Calibration Laboratory
SCOPE OF ACCREDITATION

Accreditation Number 1

| | | |
|---|--------------------|---|
| 240 nm to 380 nm | T = 0.0001 to 0.01 | 0.0002.T ^{0.2} |
| | T = 0.01 to 1.0 | 0.005.T |
| 380 nm to 1000 nm | T = 0.0001 to 1.0 | 0.0007.T ^{0.65} |
| 240 nm to 380 nm | OD = 2 to 4 | 0.000087.10 ^{0.8.OD} |
| | OD = 0 to 2 | 0.0022 |
| 380 nm to 1000 nm | OD = 0 to 4 | 0.00031.10 ^{0.35.OD} |
| (b) Wavelength calibration filters | | |
| 240 nm to 800 nm | | 0.13 nm |
| 800 nm to 1100 nm | | 0.13 nm to 0.25 nm |
| (c) Diffuse transmittance | | |
| 240 nm to 400 nm | | 0.005 to 0.0002 or 5 % of value whichever is greater |
| 400 nm to 1000 nm | | 0.0002 or 5 % of value whichever is greater |
| (d) Diffuse reflectance in 0/d and 6/d geometries | | |
| 360 nm to 1000 nm | 0.016 to 0.9 | 0.008 to 0.0036, varies with wavelength |
| 360 nm to 1000 nm | 0.9 to 1.0 | 0.4 % of value |
| (e) Specular reflectance at normal incidence | | |
| 240 nm to 800 nm | 0.05 to 1 | 1 % of value |
| (f) Bidirectional reflectance distribution factor and bidirectional radiance factor | | |
| In plane geometries only, 0.001 sr ⁻¹ to 2500 sr ⁻¹ | | |
| 360 nm to 400 nm | | 1.5 % of value |
| 400 nm to 700 nm | | 0.5 % of value |
| 700 nm to 820 nm | | 1.5 % of value |
| Representative CMCs are for 0°:45° geometry and white spectralon only. Measurement uncertainty varies with scattering geometry, radiance factor and angular dependence of scattering properties of materials. | | |

5.69 Optical Properties of Materials: Spectrally integrated

(a) Luminous transmittance

| | |
|---------------------------|----------------|
| Spectrally flat materials | 0.3 % of value |
| General materials | 5 % of value |

Operations Manager
Authorisation:

Issue 58

Date:02/11/20

Page 13 of 23



Callaghan Innovation
Metrology & Calibration Laboratory
SCOPE OF ACCREDITATION

Accreditation Number 1

| | | |
|-----|--|--------------|
| (b) | Luminous reflectance | |
| | General materials | 5 % of value |
| (c) | Colour transmitted, x, y, Y or L*a*b* | |
| | In x and y | 0.005 |
| | Luminous transmittance Y for (0.1 < Y < 1) | 5 % of value |
| (d) | Colour of surfaces, x, y, Y or L*a*b* | |
| | In x and y | 0.003 |
| | Luminance factor Y for (0.1 < Y < 1) | 5 % of value |
| (e) | Retroreflectors: CIL value | |
| | Coefficient of luminous intensity | 5 % |

5.82 Resistors, Resistance Boxes and Potential Dividers

| | | |
|-----|---|--|
| (a) | Precision resistors, resistance boxes and conductance boxes | |
| | 0.1 Ω to 1 Ω (Current ≤ 100 mA) | 0.2 μΩ/Ω |
| | 1 Ω to 10 kΩ (Power dissipation ≤ 10 mW) | 0.12 μΩ/Ω |
| | 10 mΩ to 1000 mΩ (Current ≤ 1A) | 25 μΩ/Ω |
| | 0.1 mΩ to 1000 mΩ (Current = 1 A to 875 A) | 63 R ^{-0.35} μΩ/Ω, R in mΩ values range from 141 μΩ/Ω to 6 μΩ/Ω |
| | 0.01 MΩ to 1 MΩ (Applied voltages = 5 V to 100 V) | 0.7 μΩ/Ω |
| | 0.001 GΩ to 1 GΩ (Applied voltages = 5 V to 100 V) | (0.7 + 27 R – 20 R ³) μΩ/Ω, R in GΩ, values range from 0.7 μΩ/Ω to 8 μΩ/Ω |
| | 1 MΩ to 5 TΩ (Applied voltages = 100 V to 1000 V) | (35 + 6.9 x 10 ⁻¹¹ R ² + 9.4 μΩ/Ω x 10 ⁻⁴ R) μΩ/Ω, R in MΩ, values range from 35 μΩ/Ω to 6460 μΩ/Ω |
| | 0 MΩ to 1 MΩ | (2000/f + 19 R) μΩ, f in Hz, |

Operations Manager
Authorisation:

Issue 58

Date:02/11/20

Page 14 of 23



Callaghan Innovation
Metrology & Calibration Laboratory
SCOPE OF ACCREDITATION

Accreditation Number 1

| | |
|---|---|
| (frequency, $f = 40$ Hz to 2 kHz) | R in Ω , values range from 1 $\mu\Omega$ to 19 Ω |
| (b) Volt ratio boxes and potential dividers 1 V/V to 1000 V/V (Input voltage ≤ 1100 V, output voltage ≥ 1 V) 0 kV to 50 kV | 0.4×10^{-6} 3 mV/V |
| (c) DC shunts 0.1 m Ω to 1 Ω (Applied current 1 A to 875 A) (Applied voltage 10 mV to 1 V) | $63 R^{0.35} \mu\Omega/\Omega$, R in m Ω values range from 141 $\mu\Omega/\Omega$ to 6 $\mu\Omega/\Omega$ |
| (d) AC shunts 0 Ω to 100 Ω (frequency, $f = 40$ Hz to 2 kHz) | $(2000/f + 19R) \mu\Omega$, f in Hz, R in Ω , values range from 1 $\mu\Omega$ to 1900 $\mu\Omega$ |
| 0.2 A to 100 A (frequency, $f = 47$ Hz to 75 Hz) | 25 $\mu\Omega/\Omega$ |

5.84 Capacitors

| | |
|--|--|
| (a) Precision capacitors 0 μF to 100 μF (frequency, $f = 40$ Hz to 2 kHz) | $(0.2/f + 22C)$ pF, f in Hz, C in μF , values range from 0.0001 pF to 2200 pF |
| Dissipation factor 0 to 0.2 (frequency, $f = 40$ Hz to 2 kHz) (capacitance, $C = 0.5$ pF to 100 μF) | $(0.000027 + 0.00027/C)$ C in pF values range from 0.00057 to 0.000027 |
| (c) Capacitance potential dividers 1 kV rms to 35 kV rms (frequency, $f = 50$ Hz to 3 kHz) | 1 mV/V |

5.85 Inductors and Transformers

(a) Inductors, self and mutual

| | | | | |
|--------------------------------------|--|----------|---------------|---------------|
| Operations Manager Authorisation: | | Issue 58 | Date:02/11/20 | Page 15 of 23 |
|--------------------------------------|--|----------|---------------|---------------|



Callaghan Innovation
Metrology & Calibration Laboratory
SCOPE OF ACCREDITATION

Accreditation Number 1

0 H to 100 H
(frequency, $f = 40$ Hz to 2 kHz)

$(0.2/f + 14L)H \mu\text{H}$, f in Hz
 L in H, values range from
0.0001 μH to 1400 μH

Equivalent series resistance
0 Ω to 1 M Ω
(frequency, $f = 40$ Hz to 2 kHz)

$(2000/f + 19R) \mu\Omega$, f in Hz,
 R in Ω , values range from 1
 $\mu\Omega$ to 19 Ω

(d) Current transformers: protection and measurement

Primary currents 1 A to 4000 A, ratios 0.2 A/A to 4000 A/A

Ratio error -25 % to 25 %
Phase error -36 crad to 36 crad
(frequency, $f = 50$ Hz; secondary currents 1 A, 5 A)

0.0010 % to 0.13 %
0.0010 crad to 0.18 crad

5.86 Voltage Standards and Current Standards

(b) Electronic emf reference devices

1 V
1.018 V
10 V

0.1 μV
0.1 μV
1.5 μV

5.87 Transfer Instruments (AC/DC)

0.002 V to 0.6 V
> 0.6 V to 6 V
> 6 V to 1000 V
(frequency, $f = 10$ Hz to 1 MHz)

11 $\mu\text{V/V}$ to 321 $\mu\text{V/V}$
6 $\mu\text{V/V}$ to 77 $\mu\text{V/V}$
9 $\mu\text{V/V}$ to 76 $\mu\text{V/V}$

1 V and 3 V
(frequency, $f = 1$ MHz to 100 MHz)

0.16 mV/V to 2.6 mV/V

0.1 mA to 0.01 A
(frequency, $f = 40$ Hz to 2 kHz)

15 $\mu\text{A/A}$ to 38 $\mu\text{A/A}$

0.01 A to 20 A
(frequency, $f = 40$ Hz to 100 kHz)

15 $\mu\text{A/A}$ to 70 $\mu\text{A/A}$

5.88 Calibrators for Instrumentation

(a) DC voltage

0 V to 12 V

$(0.05 + 0.15U) \mu\text{V}$, U in V,
values range from 0.05 μV to

Operations Manager
Authorisation:

Issue 58

Date:02/11/20

Page 16 of 23



Callaghan Innovation
Metrology & Calibration Laboratory
SCOPE OF ACCREDITATION

Accreditation Number 1

| | |
|--|---|
| 12 V to 1100 V | 1.85 μ V 0.5 μ V/V |
| (b) AC voltage | |
| 0.002 V to 1000 V (frequency, $f = 10$ Hz to 1 MHz) | 6 μ V/V to 650 μ V/V |
| 1 V and 3 V (frequency, $f = 1$ MHz to 100 MHz) | 0.3 mV/V to 8 mV/V |
| (c) DC current | |
| 10 pA to 10 μ A | values range from 5 μ A/A to 560 μ A/A |
| 10 μ A to 1 A | 5 μ A/A |
| 1 A to 20 A | 5 $I^{0.43}$ μ A/A, I in A, values range from 5 μ A/A to 18 μ A/A |
| 20 A to 1000 A | 5 $I^{0.43}$ μ A/A, I in A, values range from 18 μ A/A to 97 μ A/A |
| (d) AC current | |
| 0.1 mA to 2 A (frequency, $f = 40$ Hz to 2 kHz) | 35 μ A/A to 170 μ A/A |
| 0.01 A to 100 A (frequency, $f = 47$ Hz to 75 Hz) | 25 μ A/A |
| (e) Resistance | |
| 0 Ω to 10 Ω | 40 $\mu\Omega$ |
| 0.01 k Ω to 1 M Ω | 3 $\mu\Omega/\Omega$ |
| 1 M Ω to 100 M Ω | (2 + $R^{0.8}$) $\mu\Omega/\Omega$, R in M Ω , values range from 3 $\mu\Omega/\Omega$ to 42 $\mu\Omega/\Omega$ |
| (f) AC power sources | |
| Same as 5.89 (e) and (f) | |

5.89 Indicating Instruments and Recording Instruments

| | |
|-------------------|---------------------------------------|
| (a) DC voltmeters | |
| 0 V to 0.001 V | 0.05 μ V |
| 0.001 V to 12 V | (0.05 + 0.15 U) μ V, U in V, |

Operations Manager
Authorisation:

Issue 58

Date:02/11/20

Page 17 of 23



Callaghan Innovation
Metrology & Calibration Laboratory
SCOPE OF ACCREDITATION

Accreditation Number 1

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| <p>12 V to 1100 V</p> <p>(b) AC voltmeters</p> <p>0.002 V to 1000 V (frequency, $f = 10$ Hz to 1 MHz) 1 V and 3 V (frequency, $f = 1$ MHz to 100 MHz)</p> <p>(c) DC ammeters</p> <p>10 pA to 10 μA</p> <p>10 μA to 1 A 1 A to 20 A</p> <p>20 A to 875 A</p> <p>(d) AC ammeters</p> <p>0.1 mA to 2 A (frequency, $f = 40$ Hz to 2 kHz) 0.2 A to 100 A (frequency, $f = 47$ Hz to 75 Hz)</p> <p>(e) Wattmeters</p> <p>Conditions Voltage 60 V to 240 V, current 0.01 A to 120 A, frequency 45 Hz to 75 Hz, and PF 1 to 0, inductive or capacitive</p> <p>Single phase 0 W to 28.8 kW</p> <p>Three phase 0 W to 86.4 kW</p> <p>(The CMC range and uncertainties for star and delta are the same as for single-phase)</p> | <p>values range from 0.05 μV to 1.85 μV 0.5 μV/V</p> <p>9 μV/V to 862 μV/V 0.3 mV/V to 8 mV/V</p> <p>values range from 5 μA/A to 560 μA/A 5 μA/A 5 $I^{0.43}$ μA/A, I in A, values range from 5 μA/A to 18μA/A 5 $I^{0.43}$ μA/A, I in A values range from 18 μA/A to 92 μA/A</p> <p>60 μA/A to 140 μA/A 25 μA/A</p> <p>(40 μW/VA + 6(1-PF)), values range from 40 μW/VA to 46 μW/VA</p> <p>(40 μW/VA + 6(1-PF)), values range from 40 μW/VA to 46 μW/VA</p> |
|--|---|

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|-----------------------------------|--|----------|---------------|---------------|
| Operations Manager Authorisation: | | Issue 58 | Date:02/11/20 | Page 18 of 23 |
|-----------------------------------|--|----------|---------------|---------------|



Callaghan Innovation
Metrology & Calibration Laboratory
SCOPE OF ACCREDITATION

Accreditation Number 1

(f) Varmeters

Conditions

Voltage 60 V to 240 V, current 0.01 A to 120 A, frequency 45 Hz to 75 Hz, and QF 1 to 0, inductive or capacitive

0 W to 28.8 kW

(40 μ Var/VA + 90 QF), values range from 40 μ Var/VA to 130 μ Var/VA

0 W to 86.4 kW

(40 μ Var/VA + 90 QF), values range from 40 μ Var/VA to 130 μ Var/VA

(g) Phase angle indicators (source or meter)

Conditions

Current 0.01 A to 100 A, frequency 45 Hz to 75 Hz, Voltage 0.7 V to 7 V, 42 V to 240 V

-3.14 rad to 3.14 rad

40 μ rad

(h) Power factor meters

Same conditions, CMC range and uncertainties as 5.89 (g) above

(i) Ohmmeters

0.1 m Ω to 1000 m Ω
(applied current 875 A to 1 A)

63R^{0.35} $\mu\Omega/\Omega$, R in m Ω , values range from 141 $\mu\Omega/\Omega$ to 6 $\mu\Omega/\Omega$

0.1 Ω to 1 Ω
(applied current \leq 100 mA)
1 Ω to 10 k Ω
10 k Ω to 1 G Ω

0.2 $\mu\Omega/\Omega$
0.12 $\mu\Omega/\Omega$
(1 + 27R - 20R³) $\mu\Omega/\Omega$, R in G Ω , values range from 1 $\mu\Omega/\Omega$ to 8 $\mu\Omega/\Omega$

1 G Ω to 100 G Ω

(-0.07R² + 22R - 15) $\mu\Omega/\Omega$, R in G Ω , values range from 6.9 $\mu\Omega/\Omega$ to 1485 $\mu\Omega/\Omega$

100 G Ω to 1200 G Ω

(1300R + 2.2R) $\mu\Omega/\Omega$, R in G Ω , values range from 1520 $\mu\Omega/\Omega$ to 3940 $\mu\Omega/\Omega$

(k) Galvanometers and null detectors

Same CMC range and uncertainties from 5.89 (a) DC voltmeters

Operations Manager
Authorisation:

Issue 58

Date:02/11/20

Page 19 of 23



Callaghan Innovation
 Metrology & Calibration Laboratory
SCOPE OF ACCREDITATION

Accreditation Number 1

(l) Energy meters

Same as 5.89 (e) and (f)

5.90 Bridges, Potentiometers and Test Sets

(a) DC bridges

Same as 5.89 (i) Ohmmeters above

(b) DC potentiometers

Same as 5.89 (a) DC Voltmeters above

(c) AC bridges (frequency, $f = 40$ Hz to 2 kHz)

0 Ω to 1 M Ω

$(2000/f + 19R)$ $\mu\Omega$, f in Hz,
 R in Ω , values range from 1
 $\mu\Omega$ to 19 Ω

0 μF to 100 μF

$(0.2/f + 22C)$ pF, f in Hz, C in μF ,
 values range from 0.0001 pF to
 2200 pF

0 H to 1 H

$(0.2/f + 14L)$ H μH , f in Hz,
 L in H, values range from
 0.0001 μH to 14 μH

(f) Current transformer testing sets

Ratio/Phase
 (frequencies in the range 45 Hz to 65 Hz)

| | | |
|-------------|--|--|
| Ratio error | $\pm (0 \text{ to } 0.002)$ | 5.0×10^{-7} to 1.0×10^{-6} |
| Ratio error | $\pm (0.002 \text{ to } 0.02)$ | 2.0×10^{-6} to 8.0×10^{-6} |
| Ratio error | $\pm (0.02 \text{ to } 0.2)$ | 2.0×10^{-5} to 8.0×10^{-5} |
| Phase error | $\pm 0 \text{ rad to } 0.002 \text{ rad}$ | 5.0×10^{-7} rad to 1.0×10^{-6} rad |
| Phase error | $\pm 0.002 \text{ rad to } 0.02 \text{ rad}$ | 5.0×10^{-6} rad to 9.0×10^{-6} rad |
| Phase error | $\pm 0.02 \text{ rad to } 0.2 \text{ rad}$ | 5.0×10^{-5} rad to 9.0×10^{-5} rad |

(g) Voltage transformer testing sets

Same as 5.90 (f)

(i) AC and DC bridges for thermometry

Resistance
 0 Ω to 400 Ω
 (frequency, $f = \text{DC to } 100$ Hz)

$(6 + 0.3 R)$ $\mu\Omega$, R in Ω , values
 range from 6 $\mu\Omega$ to 126 $\mu\Omega$

| | | | | |
|--------------------------------------|--|----------|---------------|---------------|
| Operations Manager Authorisation: | | Issue 58 | Date:02/11/20 | Page 20 of 23 |
|--------------------------------------|--|----------|---------------|---------------|



Callaghan Innovation
 Metrology & Calibration Laboratory
SCOPE OF ACCREDITATION

Accreditation Number 1

Resistance ratio
 0 Ω/Ω to 13 Ω/Ω
 (frequency, $f = DC$ to 100 Hz) 2.6 x 10⁻⁸

5.91 Frequency Measurement and Time Measurement

Time and frequency CMC uncertainties relate only to the reference measuring systems. These uncertainties do not contain any contribution from the instrument under calibration.

(a) Frequency meters

1 Hz to 40 GHz 1 x 10⁻¹⁰
 0.001 Hz to 1 Hz (period) 1 ns

(c) Counters

1 Hz to 40 GHz 1 x 10⁻¹⁰
 0.001 Hz to 1 Hz (period) 1 ns

(d) Time interval meters

10 ns to 86400 s 2 ns or 0.27 ps/s, whichever is greatest

(g) Frequency standards

100 kHz to 10 MHz 2 x 10⁻¹³
 0.001 Hz to 1 Hz (period) 1 ns

5.92 Waveform Measurement

(a) Frequency characteristics

1 Hz to 20 MHz 1 in 10⁻¹⁰
 0.001 Hz to 1 Hz (period) 1 ns

(b) Input characteristics

1 V and 3 V 0.16 mV/V to 2.6 mV/V
 (frequency, $f = 1$ MHz to 100 MHz)

Pulse risetime ($T > 5$ ns)
 (10 mV to 10 V)

0.005 μs to 1.00 x 10⁶ μs Q(2 ns, 0.05T), T in s

Operations Manager
 Authorisation:

Issue 58

Date: 02/11/20

Page 21 of 23



Callaghan Innovation
Metrology & Calibration Laboratory
SCOPE OF ACCREDITATION

Accreditation Number 1

Pulse amplitude (pulse length > 200 μ s)
(10 mV, 100 mV, 1 V, 10 V)

0 V to 10 V

(30 μ V + 100 V_a + 420 V_r),
applied voltage V_a in V,
voltmeter range V_r in V, values
range from 34.2 μ V to 5230 μ V

(c) Timing characteristics

10 ns to 100 s
(time difference)

2 ns

5.93 Signal Sources

(a) Frequency characteristics

1 Hz to 20 MHz
0.001 Hz to 1 Hz (period)

1×10^{-10}
1 ns

(b) Output characteristics

1 V and 3 V
(frequency, $f = 1$ MHz to 100 MHz)

0.16 mV/V to 2.6 mV/V

Pulse amplitude (pulse length > 200 μ s)
(10 mV, 100 mV, 1 V, 10 V)

0 V to 10 V

(30 μ V + 100 V_a + 420 V_r)
applied voltage V_a in V,
voltmeter range V_r in V, values
range from 34.2 μ V to 5230 μ V

Pulse risetime ($T > 5$ ns)
(10 mV to 10 V)

0.005 μ s to 1.00×10^6 μ s

$Q(2$ ns, $0.05T)$, T in s

5.97 High Voltage Testing

(a) Direct voltage

0 kV to 50 kV

3 mV/V

(b) Alternating voltage

1 kV rms to 35 kV rms
(frequency, $f = 50$ Hz to 3 kHz)

1 mV/V

Operations Manager
Authorisation:

Issue 58

Date:02/11/20

Page **22** of **23**



Callaghan Innovation
Metrology & Calibration Laboratory
SCOPE OF ACCREDITATION

Accreditation Number 1

Note 1:

A CMC anticipates the performance of a best available device. Measurement uncertainties achieved for specific calibrations may be greater than CMC uncertainties, but a laboratory may not report measurement uncertainties lower than those in its CMCs. Please contact the laboratory to discuss your specific requirements.

Operations Manager
Authorisation:

A handwritten signature in black ink, appearing to read 'A. H. O. K. T. O.', is written over a light blue horizontal line.

Issue 58

Date:02/11/20

Page **23** of **23**